


<b>Search Notes</b>  	<b>Application/Control No.</b>  10531387	<b>Applicant(s)/Patent Under Reexamination</b>  FURUKAWA ET AL.
	<b>Examiner</b>  ANEETA PATANKAR	<b>Art Unit</b>  4134

SEARCHED			
Class	Subclass	Date	Examiner
369	53.3\$1, 53.33,275.1	1/31/2008	AVP

SEARCH NOTES		
Search Notes	Date	Examiner
East	1/29/08	AVP
PLUS	1/28/08	AVP
Consulted with Wayne Young	1/31/08	AVP
Consulted with Derrick Ferris	1/31/08	AVP
Consulted with Joseph Haley	1/31/08	AVP
Inventor Search	1/31/08	AVP

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner